ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

Title of Invention

PFET-BASED ESD PROTECTION STRATEGY FOR IMPROVED EXTERNAL LATCH-UP ROBUSTNESS

Application Number:

Confirmation Number:

First Named Applicant:

Kiran Chatty

Attorney Docket Number:

BUR920030045US1

Art Unit:

Examiner:

Search string:

(5140401 or 5208719 or 5287241 or 5304839 or 5440162 or 5477413 or 5479039 or 5637900 or 5644459 or 5719733 or 5745323 or 5783850 or 5869873 or 5872378 or 5907464 or 5939753 or 5946175 or 5991134 or 5998247 or 6033949 or 6040603 or 6046087 or 6157065 or 6181214 or 6215156 or 6232206 or 6256184 or 6309940 or 6337787 or 6411480 or 6417541 or 6476449 or 6563176 or 6566715 or 6566717 or 6566911 or 20010010954 or 20020105766 or 20020115250 or 20020118499 or

20020153564 or 20020154463 or 20020195663 or 20020195665).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
ON	1	5140401	1992-08-18	Ker et al.			5
1	2	5208719	1993-05-04	Wei			
	3	5287241	1994-02-15	Puar			
	4	5304839	1994-04-19	Chen et al.			
	5	5440162	1995-08-08	Worley et al.			
	6	5477413	1995-12-19	Watt)
	7	5479039	1995-12-26	Lien			
	8	5637900	1997-06-10	Ker et al.			
	9	5644459	1997-06-01	Lien			
	10	5719733	1998-02-17	Wei et al.			
	11	5745323	1998-04-27	English et al.			
\Box	12	5783850	1998-06-21	Liau et al.			
	13	5869873	1999-02-19	Yu			
\Box	14 .	5872378	1999-02-16	Rose et al.			
\sqcap	15	5907464	1999-05-25	Maloney et al.			
	16	5939753	1999-08-17	Ma et al.			
	17	5946175	1999-08-31	Yu			
$\neg \neg$	18	5991134	1999-11-23	Tan et al.			
40	19	5998247	1999-12-07	Wu			

Sut	estitute for form 1449/PTO			Complete If Known			
				Application Number	10/604,922		
11	NFORMATION	I DI	SCLOSURE	Filing Date	August 27, 2003		
S	TATEMENT E	3Y /	APPLICANT	First Named Inventor	Kiran V. CHATTY		
				Art Unit	To Be Assigned		
(use as many sheets as necessary)		necessary)	Examiner Name	To Be Assigned			
Sheet	1	of	1	Attorney Docket Number	BUR920030045US1		

	U.S. PATENT DOCUMENTS								
Examiner	CN	Document Number	Publication Date	Name	A Da	tentee	0.5		Pages, Columns, Lines, Where
Initials*	Cite No.'	Number-Kind Code ² (# known)	MM-DD-YYYY	Applicant					Relevant Passages or Relevant Figures Appear
oN		2003/0062539	04-03-2003	Chatterjee				1.	1 0
		4,669,177	06-02-1987	D'Arrigo et al.			1	. 1	10.000
		5,543,650	08-06-1996	Au et al.	7	- 0	الملا	راب	Alex
		5,733,794	03-31-1998	Gilbert et al.	$\overline{}$	ענד		NEW TON	,3·
T		6,153,913	11-28-2000	Hsu et al.	7	A	J. Commercial Commerci	12	
		6,228,726 B1	05-08-2001	Liaw	$\neg au$	V	ab.		
		6,476,449 B1	11-05-2002	Lin	7	5	4		
0,1		6,493,199 B1	12-10-2002	Su et al.	J				

	FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁸ (** known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶	
UN	J	EP 1045444 A1	10-18-2000	Chen			
2N		JP 10-50494	02-20-1998	Knight et al.			
<i>JN</i>		JP 10-294445	11-04-1998	Szafranski et al.			

"EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. Applicant's unique citation designation number (optional). See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. The reign of the triangular that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. Nind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS						
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T°			
ON	1	Ming-Dou KER, "ESD Protection for CMOS Output Buffer by Using Modified LVTSCR Devices with High Trigger Current," IEEE Journal of Solid State Circuits, Vol. 32, No. 8, Aug. 1997, pp. 1293-96.				
	j	Ming-Dou KER and Hun-Hsien CHANG, "How to Safely Apply the LVTSCR for CMOS Whole-Chip ESD Protection without being Accidentally Triggered On," 1998 EOS/ESD Symposium, pp. 72-85.				
	J	Jeremy C. SMITH, "An Anti-Snapback Circuit Technique for Inhibiting Parasitic Bipolar Condition During EOS/ESD Events," 1999 EOS/ESD Symposium, pp. 62-69.				
	丿.	Teruo SUZUKI et al., "A Study of Fully Silicided 0.18um CMOS ESD Protection Devices," 1999 EOS/ESD Symposium, pp. 78-87.				
01	1.	Gianluca BOSELLI et al., "Efficient pnp Characteristics of pMOS Transistors in Sub-0.13um ESD Protection Circuits," 2002 EOS/ESD Symposium, pp. 257-66.				
	_		T			

^{*}EXAMINER: Initial If reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

^{&#}x27;Applicant's unique citation designation number (optional). ³Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	ON	Date Considered	11/11/04
Signature		Considered	

UN	36	6566911	2003-05-20	Moyer		
	35	6566717	2003-05-20	Jung		
	34	6566715	2003-05-20	Ker et al.		
				al.		
	33	6563176	2003-05-13	Gauthier, Jr. et		
	32	6476449	2002-11-05	Lin		
	31	6417541	2002-07-09	Cai et al.		
	30	6411480	2002-06-25	Gauthier et al.		
	29	6337787	2002-01-08	Tang		
	28	6309940	2001-10-30	Lee		
				al.		
	27	6256184	2001-07-03	Gauthier, Jr. et	<u></u>	
	26	6232206	2001-05-15	Huang et al.		
	25	6215156	2001-04-10	Yang		
	24	6181214	2001-01-30	Schmitt et al.		
	23	6157065	2000-12-05	Huang et al.		
	22	6046087	2000-04-04	Lin et al.		
	21	6040603	2000-03-21	Yang		
20	20	6033949	2000-03-07	Baker et al.		

US Published Applications

Note: Applicant is not required to submit a paper copy of cited US Published Applications

	init	Cite.No.		Date	Applicant	Kind	Class	Subclass
Z	1/6	1	20010010954		Lin et al.			
		2	20020105766	2002-08-08	Lin et al.			
		3	20020115250	2002-08-22	Jiang et al.			
		4	20020118499	2002-08-29	Gossner			
		5	20020153564	2002-10-24	Shirai			
		6	20020154463	2002-10-24	Mergens et al.			
	T	7	20020195663	2002-12-26	Ramsbey et al.			Λ
	אקט	8	20020195665	2002-12-26	Jun et al.			

Signature

Examiner Name	Date
<i>∂</i> ~	11/17/04